

Search Terms	
1	CENTER
2	CENTERS
3	CENTRE
4	CENTRES
5	CENTROID
6	CENTROIDS
7	EXTREMA
8	EXTREMAS
9	LASER
10	LASERS
11	MAX
12	MAXES
13	MAXIMA
14	MAXIMUM
15	MAXIMUMS
16	MIN
17	MINIMA
18	MINIMUM
19	MINIMUMS
20	MINS
21	REFLECT
22	REFLECTED
23	REFLECTING
24	REFLECTINGS
25	REFLECTION
26	REFLECTIONS
27	REFLECTS
28	SLOPE
29	SLOPED
30	SLOPES
31	SLOPING
32	TARGET
33	TARGETS
34	SLOPINGS
35	(((SLOPED OR SLOPING OR SLOPE) AND MAXIMA) AND (REFLECT OR REFLECTING OR REFLECTION OR REFLECTIONS)) AND ((TARGET SAME (CENTROID OR CENTER)) SAME (EXTREMA OR MAXIMA OR MINIMA)) AND LASER)

	Total	USPAT	US-PGPUB	EPO	JPO	Derwent	IBM TDB	USOCR
1	1574456							
2	165363							
3	391993							
4	32910							
5	12840							
6	2917							
7	1915							
8	18							
9	700343							
10	78631							
11	231260							
12	36							
13	23610							
14	1332411							
15	4131							
16	583823							
17	10246							
18	1041024							
19	3303							
20	71952							
21	295469							
22	493363							
23	275671							
24	5							
25	315806							
26	58428							
27	152123							
28	231342							
29	62783							
30	68939							
31	114793							
32	573438							
33	99579							
34	20							
35	106	68	37	0	0	0	0	1

U	1	Document ID	Issue Date	Pages	Title	Current OR
1	<input checked="" type="checkbox"/>	US 20040090553 A1	20040513	317	Monolithic integrated circuit with a printhead interface	348/375
2	<input checked="" type="checkbox"/>	US 20040080620 A1	20040429		Integrated circuit for a digital camera system	348/207.2
3	<input checked="" type="checkbox"/>	US 20040075821 A1	20040422		Method of capturing and processing sensed images	355/18
4	<input checked="" type="checkbox"/>	US 20040075747 A1	20040422		Monolithic integrated circuit having a number of programmable processing elements	348/207.99
5	<input checked="" type="checkbox"/>	US 20040065738 A1	20040408		Data distribution mechanism in the form of ink dots on cards	235/454
6	<input checked="" type="checkbox"/>	US 20040061734 A1	20040401	310	Printing device for use with a printing cartridge having capacitive sensor identification	347/19
7	<input checked="" type="checkbox"/>	US 20040056105 A1	20040325		Data structure encoded on a surface of an object	235/494
8	<input checked="" type="checkbox"/>	US 20040051753 A1	20040318		Method of identifying printing cartridge characteristics with capacitive sensors	347/19
9	<input checked="" type="checkbox"/>	US 20040041018 A1	20040304		Card having coded data and visible information, for operating a device	235/375
10	<input checked="" type="checkbox"/>	US 20040039378 A1	20040226		Selective photocoagulation	606/6
11	<input checked="" type="checkbox"/>	US 20040010375 A1	20040115		Methods and apparatus for processing spectral data for use in tissue characterization	702/19
12	<input checked="" type="checkbox"/>	US 20040008327 A1	20040115		Image printing apparatus including a microcontroller	355/18
13	<input checked="" type="checkbox"/>	US 20040008262 A1	20040115		Utilization of color transformation effects in photographs	348/207.2
14	<input checked="" type="checkbox"/>	US 20040008261 A1	20040115		Print roll for use in a camera imaging system	348/207.2
15	<input checked="" type="checkbox"/>	US 2004004698 A1	20040108		Programmable camera system with software interpreter	355/18
16	<input checked="" type="checkbox"/>	US 2004004651 A1	20040108		Printing cartridge with a data-carrying integrated circuit device	347/86
17	<input checked="" type="checkbox"/>	US 2004004129 A1	20040108		Identifying card	235/487
18	<input checked="" type="checkbox"/>	US 20030214654 A1	20031120		Spatial averaging technique for ellipsometry and reflectometry	356/369
19	<input checked="" type="checkbox"/>	US 20030117496 A1	20030626		Preprinted print rolls for postal use in an image processing device	348/207.2
20	<input checked="" type="checkbox"/>	US 20030112419 A1	20030619		Printing cartridge with barcode identification	355/18
21	<input checked="" type="checkbox"/>	US 20030103189 A1	20030605		Characterizing aberrations in an imaging lens and applications to visual testing and integrated circuit mask analysis	351/176

	Current XRef	Retrieval Classif	Inventor	S	C	P	2	3	4	5	Image Doc. Displayed	PT
1			Silverbrook, Kia	<input type="checkbox"/>								
2			Silverbrook, Kia	<input type="checkbox"/>								
3			Silverbrook, Kia	<input type="checkbox"/>								
4			Silverbrook, Kia	<input type="checkbox"/>								
5			Silverbrook, Kia et al.	<input type="checkbox"/>								
6			Silverbrook, Kia	<input type="checkbox"/>								
7			Silverbrook, Kia et al.	<input type="checkbox"/>								
8			Silverbrook, Kia	<input type="checkbox"/>								
9			Silverbrook, Kia et al.	<input type="checkbox"/>								
10			Silverbrook, Kia et al.	<input type="checkbox"/>								
11			Schomacker, Kevin T. et al.	<input type="checkbox"/>								
12			Silverbrook, Kia	<input type="checkbox"/>								
13	348/222.1; 348/231.3; 348/231.7		Silverbrook, Kia et al.	<input type="checkbox"/>								
14	348/222.1; 348/239		Silverbrook, Kia	<input type="checkbox"/>								
15			Silverbrook, Kia et al.	<input type="checkbox"/>								
16			Silverbrook, Kia	<input type="checkbox"/>								
17			Silverbrook, Kia	<input type="checkbox"/>								
18	257/E21.53		Wei, Lanhua et al.	<input type="checkbox"/>								
19			Silverbrook, Kia	<input type="checkbox"/>								
20	355/35; 355/40; 355/41		Silverbrook, Kia	<input type="checkbox"/>								
21	351/177		Neureuther, Andrew R. et al.	<input type="checkbox"/>								

U	1	Document ID	Issue Date	Pages	Title	Current OR
22	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20030089899 A1	20030515		Nanoscale wires and related devices	257/9
23	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20030089219 A1	20030515		SYSTEM AND METHOD FOR DISABLING TIME CRITICAL TARGETS	89/1.11
24	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20030089162 A1	20030515		Dual stage instrument for scanning a specimen	73/105
25	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20030068185 A1	20030410		Printing cartridge with switch array identification	400/613
26	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20030047680 A1	20030313		Electroosmotic fluidic device and related methods	250/288
27	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20030038933 A1	20030227		Calibration apparatus, system and method	356/243.1
28	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20020130311 A1	20020919		Doped elongated semiconductors, growing such semiconductors, devices including such semiconductors and fabricating such devices	257/1
29	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20020080335 A1	20020627		Printing cartridge with capacitive sensor identification	355/18
30	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20020071104 A1	20020613		Image sensing apparatus including a microcontroller	355/18
31	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20020045284 A1	20020418		Spatial averaging technique for ellipsometry and reflectometry	438/16
32	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20020033854 A1	20020321		Printing cartridge with pressure sensor array identification	347/17
33	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20020030713 A1	20020314		Printing cartridge with two dimensional code identification	347/19
34	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20020030712 A1	20020314		Printing cartridge with an integrated circuit device	347/19
35	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20020012123 A1	20020131		Spatial averaging technique for ellipsometry and reflectometry	356/369
36	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20010047682 A1	20011206		Dual stage instrument for scanning a specimen	73/105
37	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 20010022663 A1	20010920		Method for image formation and apparatus for development processing	358/1.9
38	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 6702417 B2	20040309		Printing cartridge with capacitive sensor identification	347/19
39	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 6665454 B1	20031216		Dot adjacency compensation in optical storage systems using ink dots	382/299
40	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 6644771 B1	20031111		Printing cartridge with radio frequency identification	347/19
41	<input checked="" type="checkbox"/>	<input type="checkbox"/> US 6636216 B1	20031021		Digital image warping system	345/427

	Current XRef	Retrieval Classif	Inventor	S	C	P	2	3	4	5	Image Doc. Displayed	PT
22	257/E51.04		Lieber, Charles M. et al.	<input type="checkbox"/>								
23			Gorman, Richard	<input type="checkbox"/>								
24			Samsavar, Amin et al.	<input type="checkbox"/>								
25	355/18		Silverbrook, Kia	<input type="checkbox"/>								
26			Figeys, Daniel et al.	<input type="checkbox"/>								
27			Shirley, Lyle G. et al.	<input type="checkbox"/>								
28	257/E51.04		Lieber, Charles M. et al.	<input type="checkbox"/>								
29	355/38;		Silverbrook, Kia	<input type="checkbox"/>								
30	355/40; 355/41		Silverbrook, Kia	<input type="checkbox"/>								
31	257/E21.53		Wei, Lanhua et al.	<input type="checkbox"/>								
32	347/19; 347/5		Silverbrook, Kia	<input type="checkbox"/>								
33	347/5		Silverbrook, Kia	<input type="checkbox"/>								
34	347/86		Silverbrook, Kia	<input type="checkbox"/>								
35	257/E21.53; 438/14		Wei, Lanhua et al.	<input type="checkbox"/>								
36			Samsavar, Amin et al.	<input type="checkbox"/>								
37	358/518		Ishikawa, Takatoshi et al.	<input type="checkbox"/>								
38	347/86; 399/12		Silverbrook, Kia	<input type="checkbox"/>								
39	345/596; 345/698; 358/1.7; 358/1.8;		Silverbrook, Kia et al.	<input type="checkbox"/>								
40	347/6		Silverbrook, Kia	<input type="checkbox"/>								
41	345/646		Silverbrook, Kia et al.	<input type="checkbox"/>								

U	1	Document ID	Issue Date	Pages	Title	Current OR
42	<input checked="" type="checkbox"/>	US 6618117 B2	20030909		Image sensing apparatus including a microcontroller	355/18
43	<input checked="" type="checkbox"/>	US 6594388 B1	20030715		Color image reproduction of scenes with preferential color mapping and scene-dependent tone scaling	382/167
44	<input checked="" type="checkbox"/>	US 6584879 B2	20030701		System and method for disabling time critical targets	891.11
45	<input checked="" type="checkbox"/>	US 6577384 B2	20030610		Spatial averaging technique for ellipsometry and reflectometry	356/73
46	<input checked="" type="checkbox"/>	US 6576896 B2	20030610		Electroosmotic fluidic device and related methods	259/288
47	<input checked="" type="checkbox"/>	US 6565181 B2	20030520		Printing cartridge with switch array identification	347/19
48	<input checked="" type="checkbox"/>	US 6547364 B2	20030415		Printing cartridge with an integrated circuit device	347/19
49	<input checked="" type="checkbox"/>	US 6542645 B1	20030401		Adaptive tracking of dots in optical storage system using ink dots	382/254
50	<input checked="" type="checkbox"/>	US 6529280 B1	20030304		Three-dimensional measuring device and three-dimensional measuring method	356/602
51	<input checked="" type="checkbox"/>	US 6520643 B1	20030218		Image projection system	353/20
52	<input checked="" type="checkbox"/>	US 6496280 B2	20021217		Method for image formation and apparatus for development processing	358/1.9
53	<input checked="" type="checkbox"/>	US 6476863 B1	20021105		Image transformation means including user interface	348/231.9
54	<input checked="" type="checkbox"/>	US 6459495 B1	20021001		Dot center tracking in optical storage systems using ink dots	358/520
55	<input checked="" type="checkbox"/>	US 6442525 B1	20020827		System for authenticating physical objects	705/1

	Current XRef	Retrieval Classif	Inventor	S	C	P	2	3	4	5	Image D c. Displayed	PT
42	348/207.99		Silverbrook, Kia	<input type="checkbox"/>								
43	358/520		Gindelé, Edward B. et al.	<input type="checkbox"/>								
44			Gorman, Richard	<input type="checkbox"/>								
45	257/E21.53; 356/369; 356/445		Wei, Lanhua et al.	<input type="checkbox"/>								
46			Figeys, Daniel et al.	<input type="checkbox"/>								
47	347/214; 347/86; 399/12		Silverbrook, Kia	<input type="checkbox"/>								
48	347/86		Silverbrook, Kia	<input type="checkbox"/>								
49	235/437; 382/309		Silverbrook, Kia et al.	<input type="checkbox"/>								
50	356/606		Yahashi, Akira et al.	<input type="checkbox"/>								
51	349/9		Holman, Robert L. et al.	<input type="checkbox"/>								
52	358/327; 358/518; 358/527; 358/532		Ishikawa, Takatoshi et al.	<input type="checkbox"/>								
53			Silverbrook, Kia	<input type="checkbox"/>								
54			Silverbrook, Kia	<input type="checkbox"/>								
55	235/379; 235/380; 235/382; 348/441; 348/460; 348/552; 380/30; 705/51; 705/52; 705/64; 705/67; 705/71; 713/169; 713/180		Silverbrook, Kia et al.	<input type="checkbox"/>								

U	1	Document ID	Issue Date	Pages	Title	Current OR
56	<input checked="" type="checkbox"/>	US 6431669 B1	20020813		Method and apparatus for information storage in a portable print roll	347/2
57	<input checked="" type="checkbox"/>	US 6416154 B1	20020709		Printing cartridge with two dimensional code identification	347/19
58	<input checked="" type="checkbox"/>	US 6415054 B1	20020702		Target detection for dot region alignment in optical storage systems using ink dots	382/233
59	<input checked="" type="checkbox"/>	US 6396069 B1	20020528		Topographer for real time ablation feedback having synthetic wavelength generators	250/559.22
60	<input checked="" type="checkbox"/>	US 6375327 B2	20020423		Image projection system	353/20
61	<input checked="" type="checkbox"/>	US 6362869 B1	20020326		Authentication system for camera print rolls	355/18
62	<input checked="" type="checkbox"/>	US 6362868 B1	20020326		Print media roll and ink replaceable cartridge	355/18
63	<input checked="" type="checkbox"/>	US 6356715 B1	20020312		Prints remaining indicating for camera with variable length print capability	396/284
64	<input checked="" type="checkbox"/>	US 6317192 B1	20011113		Utilization of image tiling effects in photographs	355/18
65	<input checked="" type="checkbox"/>	US 6315412 B1	20011113		Method and apparatus for measuring visual sensitivity and optical properties of components of the eye	351/200
66	<input checked="" type="checkbox"/>	US 6315200 B1	20011113		Encoded data card reading system	235/454
67	<input checked="" type="checkbox"/>	US 6306036 B1	20011023		Computer game with replaceable character heads	463/31
68	<input checked="" type="checkbox"/>	US 6281027 B1	20010828		Spatial averaging technique for ellipsometry and reflectometry	438/14
69	<input checked="" type="checkbox"/>	US 6267005 B1	20010731		Dual stage instrument for scanning a specimen	73/105
70	<input checked="" type="checkbox"/>	US 6217165 B1	20010417		Ink and media cartridge with axial ink chambers	347/86
71	<input checked="" type="checkbox"/>	US 6213606 B1	20010410		Image projection system	353/20
72	<input checked="" type="checkbox"/>	US 6207360 B1	20010327		Method for image formation and apparatus for development processing	430/434
73	<input checked="" type="checkbox"/>	US 6141105 A	20001031		Three-dimensional measuring device and three-dimensional measuring method	356/623

	Current XRef	Retrieval Classif	Inventor	S	C	P	2	3	4	5	Image Doc. Displayed	PT
56	358/296		Silverbrook, Kia	<input type="checkbox"/>								
57	347/14		Silverbrook, Kia	<input type="checkbox"/>								
58			Silverbrook, Kia et al.	<input type="checkbox"/>								
59			MacPherson, David C. et al.	<input type="checkbox"/>								
60	349/9; 359/501		Holman, Robert L. et al.	<input type="checkbox"/>								
61	347/101; 347/19		Silverbrook, Kia	<input type="checkbox"/>								
62	347/86; 355/72; 399/12		Silverbrook, Kia	<input type="checkbox"/>								
63	347/101; 396/429; 396/515		Silverbrook, Kia	<input type="checkbox"/>								
64	347/2; 348/222.1; 396/429		Silverbrook, Kia et al.	<input type="checkbox"/>								
65	351/208		Snodderly, D. Max et al.	<input type="checkbox"/>								
66	235/462.01; 235/462.1; 235/462.24; 235/470		Silverbrook, Kia et al.	<input type="checkbox"/>								
67	463/32		Burns, Patrick et al.	<input type="checkbox"/>								
68	257/E21.53; 438/15; 438/16		Wei, Lanhua et al.	<input type="checkbox"/>								
69	250/306		Samsavar, Amin et al.	<input type="checkbox"/>								
70			Silverbrook, Kia	<input type="checkbox"/>								
71	349/9; 359/501		Holman, Robert L. et al.	<input type="checkbox"/>								
72	430/419; 430/428; 430/963		Ishikawa, Takatoshi et al.	<input type="checkbox"/>								
73			Yahashi, Akira et al.	<input type="checkbox"/>								

	U	1	Document ID	Issue Date	Pages	Title	Current OR
74	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 6067391 A	20000523		Multiply periodic refractive index modulated optical filters	385/27
75	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 6000612 A	19991214		Portable data collection device having optical character recognition	235/454
76	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 5986761 A	19991116		Laser-based inspection tool for disk defects and curvature	356/600
77	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 5975703 A	19991102		Image projection system	353/20
78	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 5948972 A	19990907		Dual stage instrument for scanning a specimen	73/105
79	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 5905567 A	19990518		Method and apparatus for optimizing sub-pixel resolution in a triangulation based distance measuring device	356/3.06
80	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 5844140 A	19981201		Ultrasound beam alignment servo	73/633
81	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 5818383 A	19981006		Interferometric moving vehicle imaging apparatus and method	342/109
82	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 5731994 A	19980324		Method of packing particles into vessels and apparatus therefor	702/128
83	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 5671200 A	19970923		Method for detecting the movement of a light beam and optical information reproduction apparatus using the same	369/44.28
84	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 5627635 A	19970506		Method and apparatus for optimizing sub-pixel resolution in a triangulation based distance measuring device	356/3.06
85	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 5587463 A	19961224		Tetraphyrin macrocycles and metal complexes thereof	534/15

	Current XRef	Retrieval Classif	Inventor	S	C	P	2	3	4	5	Image Doc. Displayed	PT
74	385/37		Land, Peter L.	<input type="checkbox"/>								
	235/462.11;			<input type="checkbox"/>								
75	235/462.45;		Xu, Jianhua	<input type="checkbox"/>								
	382/176			<input type="checkbox"/>								
76			Crawforth, Linden et al.	<input type="checkbox"/>								
				<input type="checkbox"/>								
77	349/9;		Holman, Robert L. et al.	<input type="checkbox"/>								
	359/501			<input type="checkbox"/>								
78			Samsavar, Amin et al.	<input type="checkbox"/>								
				<input type="checkbox"/>								
	250/201.6;			<input type="checkbox"/>								
	250/559.25;			<input type="checkbox"/>								
79	356/613;		Dewan, Brian	<input type="checkbox"/>								
	356/628			<input type="checkbox"/>								
	310/90.5;			<input type="checkbox"/>								
	600/437;			<input type="checkbox"/>								
80	600/443;		Seale, Joseph B.	<input type="checkbox"/>								
	600/453;			<input type="checkbox"/>								
	73/620;			<input type="checkbox"/>								
	73/621			<input type="checkbox"/>								
81	342/161		Stockburger, Edward F. et al.	<input type="checkbox"/>								
	141/1;			<input type="checkbox"/>								
	141/286;			<input type="checkbox"/>								
82	422/219;		Okubo, Shuichi et al.	<input type="checkbox"/>								
	422/232;			<input type="checkbox"/>								
	422/301;			<input type="checkbox"/>								
	73/865.5			<input type="checkbox"/>								
	369/44.29;			<input type="checkbox"/>								
83	369/44.35		Yamaguchi, Osamu et al.	<input type="checkbox"/>								
				<input type="checkbox"/>								
84	250/201.6;		Dewan, Brian	<input type="checkbox"/>								
	250/559.25;			<input type="checkbox"/>								
	356/627			<input type="checkbox"/>								
	534/11;			<input type="checkbox"/>								
85	540/145;			<input type="checkbox"/>								
	540/465;			<input type="checkbox"/>								
	540/472;			<input type="checkbox"/>								
	540/474			<input type="checkbox"/>								

U	1	Document ID	Issue Date	Pages	Title	Current OR
86	<input checked="" type="checkbox"/>	US 5525325 A	19960611		Expanded porphyrins: large porphyrin-like tripyrrolidimethine-derived macrocycles	424/9.6
87	<input checked="" type="checkbox"/>	US 5520356 A	19960528		System for propelling and guiding a solid object with a beam of electromagnetic radiation	244/62
88	<input checked="" type="checkbox"/>	US 5369101 A	19941129		Expanded porphyrins: large porphyrin-like tripyrrolidimethine-derived macrocycles	534/13
89	<input checked="" type="checkbox"/>	US 5293312 A	19940308		Method and apparatus for computing tomographic scans	378/14
90	<input checked="" type="checkbox"/>	US 5292414 A	19940308		Expanded porphyrins: large porphyrin-like tripyrrolidimethine-derived macrocycles for singlet oxygen production	204/157.5
91	<input checked="" type="checkbox"/>	US 5272142 A	19931221		Expanded porphyrins: large porphyrin-like tripyrrolidimethine-derived macrocycles and methods for treating tumors	514/185
92	<input checked="" type="checkbox"/>	US 5256399 A	19931026		Aromatic pentadentate expanded porphyrins in magnetic resonance imaging	424/9.362
93	<input checked="" type="checkbox"/>	US 5179383 A	19930112		Synthetic aperture radar processor to handle large squint with high phase and geometric accuracy	342/25
94	<input checked="" type="checkbox"/>	US 5162509 A	19921110		Process for preparing expanded porphyrins: large porphyrin-like tripyrrolidimethine-derived macrocycles	534/15
95	<input checked="" type="checkbox"/>	US 5112126 A	19920512		Apparatuses and methods for making geophysical measurements useful in determining the deflection of the vertical	356/141.5

	Current XRef	Retrieval Classif	Inventor	S	C	P	2	3	4	5	Image Doc. Displayed	PT
	424/9,61; 435/2; 436/2; 514/185; 514/410; 514/836; 540/145; 540/472		Sessler, Jonathan L. et al.	<input type="checkbox"/>								
86				<input type="checkbox"/>								
87	244/172; 60/203.1		Ensley, Donald L.	<input type="checkbox"/>								
88	534/16; 540/145; 540/465; 540/472		Sessler, Jonathan L. et al.	<input type="checkbox"/>								
89			Waggener, Robert G.	<input type="checkbox"/>								
90			Sessler, Jonathan L. et al.	<input type="checkbox"/>								
91	435/2; 514/836; 514/908; 534/15; 540/145		Sessler, Jonathan L. et al.	<input type="checkbox"/>								
92	436/173; 436/806; 514/185; 514/836; 534/15; 540/145		Sessler, Jonathan L. et al.	<input type="checkbox"/>								
93	342/25D		Raney, R. K. et al.	<input type="checkbox"/>								
94	534/16; 540/465; 540/472		Sessler, Jonathan L. et al.	<input type="checkbox"/>								
95	33/283; 33/304; 33/306; 33/309; 356/148; 356/149; 356/250		Graebner, Peter	<input type="checkbox"/>								

U	1	Document ID	Issue Date	Pages	Title	Current OR
96	<input checked="" type="checkbox"/>	US 5020411 A	19910604		Mobile assault logistic kinematic engagement device	89/1.11
97	<input checked="" type="checkbox"/>	US 4935498 A	19900619		Expanded porphyrins: large porphyrin-like tripyrrolidimethine-derived macrocycles	534/15
98	<input checked="" type="checkbox"/>	US 4914725 A	19900403		Transducer positioning servo mechanisms employing digital and analog circuits	318/560
99	<input checked="" type="checkbox"/>	US 4825394 A	19890425		Vision metrology system	356/147
100	<input checked="" type="checkbox"/>	US 4807131 A	19890221		Grading system	701/50
101	<input checked="" type="checkbox"/>	US 4735762 A	19880405		Laser or charged-particle-beam fusion reactor with direct electric generation by magnetic flux compression	376/102
102	<input checked="" type="checkbox"/>	US 4666295 A	19870519		Linear FM chirp laser	356/5.09
103	<input checked="" type="checkbox"/>	US 3847080 A	19741112		REMOTE ROCK BREAKING METHOD APPARATUS THEREFOR	102/311
104	<input checked="" type="checkbox"/>	US 3741119 A	19730626		REMOTE ROCK BREAKING METHOD APPARATUS THEREFOR	102/310
105	<input checked="" type="checkbox"/>	US 3644043 A	19720222		INTEGRATED INFRARED-TRACKER-RECEIVER LASER-RANGEFINDER TARGET SEARCH AND TRACK SYSTEM	356/5.08
106	<input checked="" type="checkbox"/>	NN9202136	19920201		Scan Angle Multiplying and Twisted Mirrors for Bar Code Scanner or Laser Printer.	

	Current XRef	Retrieval Classif	Inventor	S	C	P	2	3	4	5	Image D c. Displayed	PT
96	376/319; 60/203.1; 89/8		Rowan, Larry	<input type="checkbox"/>								
97	534/11; 540/145; 540/465; 540/477		Sessler, Jonathan L. et al.	<input type="checkbox"/>								
98	318/561; 318/563; 360/77.06; 360/77.08; 360/78.05		Belser, Karl A. et al.	<input type="checkbox"/>								
99			Beamish, Jerald K. et al.	<input type="checkbox"/>								
100	172/4.5; 37/382; 37/907		Clegg, Philip M.	<input type="checkbox"/>								
101	376/101; 376/146; 376/147; 376/152; 976/DIG.3		Lasche, George P.	<input type="checkbox"/>								
102	342/201; 356/28.5; 359/321; 372/12; 372/28; 372/32		Duvall, III, Robert L. et al.	<input type="checkbox"/>								
103			Eckels, Robert E.	<input type="checkbox"/>								
104	102/311		Eckels, Robert E.	<input type="checkbox"/>								
105	250/203.1; 250/203.3; 356/141.1; 356/141.5; 89/41.06		Jones, Sheldon et al.	<input type="checkbox"/>								
106				<input type="checkbox"/>								

Search Terms	
1	LEROUX-PIERRE
2	((HUBBARD-BRYAN.IN.) OR (LEROUX-PIERRE.IN.))

	Total	USPAT	US-PGPUB	EPO	IPO	Derwent	IBM TDB	USOCR
1	25							
2	25	20	4	1	0	0	0	

U	1	Document ID	Issue Date	Pages	Title	Current OR
1	<input type="checkbox"/>	US 20030232253 A1	20031218	10	Techniques to characterize iso-dense effects for microdevice manufacture	430/5
2	<input checked="" type="checkbox"/>	US 20030152848 A1	20030814	12	Calibration wafer for a stepper	430/22
3	<input checked="" type="checkbox"/>	US 20020048922 A1	20020425	21	Semiconductor processing methods and structures for determining alignment during semiconductor wafer processing	438/597
4	<input checked="" type="checkbox"/>	US 20010051441 A1	20011213	21	SEMICONDUCTOR PROCESSING METHODS AND STRUCTURES FOR DETERMINING ALIGNMENT DURING SEMICONDUCTOR WAFER PROCESSING	438/758
5	<input checked="" type="checkbox"/>	US 6671048 B1	20031230	18	Method for determining wafer misalignment using a pattern on a fine alignment target	356/401
6	<input checked="" type="checkbox"/>	US 6639676 B1	20031028	29	Method for determining rotational error portion of total misalignment error in a stepper	356/401
7	<input checked="" type="checkbox"/>	US 6544859 B2	20030408	20	Semiconductor processing methods and structures for determining alignment during semiconductor wafer processing	438/401
8	<input checked="" type="checkbox"/>	US 6541283 B1	20030401	30	Method for determining magnification error portion of total misalignment error in a stepper	438/7
9	<input checked="" type="checkbox"/>	US 6465322 B2	20021015	22	Semiconductor processing methods and structures for determining alignment during semiconductor wafer processing	438/401
10	<input checked="" type="checkbox"/>	US 6301008 B1	20011009	15	Arrangement and method for calibrating optical line shortening measurements	356/401
11	<input checked="" type="checkbox"/>	US 6258611 B1	20010710	19	Method for determining translation portion of misalignment error in a stepper	438/14
12	<input checked="" type="checkbox"/>	US 5976741 A	19991102	14	Methods for determining illumination exposure dosage	430/30
13	<input checked="" type="checkbox"/>	US 5972051 A	19991026	9	Method and apparatus for removing particles from semiconductor wafer edges using a particle withdrawing means	29/25.01
14	<input checked="" type="checkbox"/>	US 5962173 A	19991005	9	Method for measuring the effectiveness of optical proximity corrections	430/5
15	<input checked="" type="checkbox"/>	US 5960107 A	19990928	17	Method for verifying an average topography height function of a photostepper	382/145

	Current XRef	Retrieval Classif	Inventor	S	C	P	2	3	4	5	Image D c. Displayed	PT
1	250/311; 430/30; 430/311	Leroux, Pierre et al.	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 2003023253	<input type="checkbox"/>						
2		Leroux, Pierre et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US 20030152848	<input type="checkbox"/>
3		Ziger, David et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US 20020048922	<input type="checkbox"/>
4		ZIGER, DAVID et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US 20010051441	<input type="checkbox"/>
5		Leroux, Pierre	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US 6671048	<input type="checkbox"/>
6		Leroux, Pierre	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US 6639676	<input type="checkbox"/>
7	438/14; 438/975	Ziger, David et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US 6544859	<input type="checkbox"/>
8	430/311	Leroux, Pierre	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US 6541283	<input type="checkbox"/>
9	148/DIG.102; 438/14; 438/975	Ziger, David et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US 6465322	<input type="checkbox"/>
10	250/559.3; 356/400	Ziger, David et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US 6301008	<input type="checkbox"/>
11	430/312; 430/394; 438/16; 438/401	Leroux, Pierre	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US 6258611	<input type="checkbox"/>
12	382/145	Ziger, David et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US 5976741	<input type="checkbox"/>
13	134/1.3; 15/151; 257/E21.214; 438/906	Leroux, Pierre et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US 5972051	<input type="checkbox"/>
14	356/620; 430/22; 430/394	Leroux, Pierre et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US 5962173	<input type="checkbox"/>
15	356/618	Leroux, Pierre	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	US 5960107	<input type="checkbox"/>

U	1	Document ID	Issue Date	Pages	Title	Current OR
16	<input checked="" type="checkbox"/>	US 5902703 A	1990511	8	Method for measuring dimensional anomalies in photolithographed integrated circuits using overlay metrology, and masks therefor	430/5
17	<input checked="" type="checkbox"/>	US 587683 A	1990302	13	Method forming focus/exposure matrix on a wafer using overlapped exposures	430/22
18	<input checked="" type="checkbox"/>	US 5856052 A	1990105	13	Wafer with a focus/exposure matrix	430/18
19	<input checked="" type="checkbox"/>	US 5830610 A	19981103	14	Method for measuring alignment accuracy in a step and repeat system utilizing different intervals	430/22
20	<input checked="" type="checkbox"/>	US 5780208 A	19980714	8	Method and mask design to minimize reflective notching effects	430/394
21	<input checked="" type="checkbox"/>	US 5762688 A	19980609	7	Particle removal wafer	95/212
22	<input checked="" type="checkbox"/>	US 5407785 A	19950418	5	Method for generating dense lines on a semiconductor wafer using phase-shifting and multiple exposures	430/312
23	<input checked="" type="checkbox"/>	US 5392113 A	19950221	6	Semiconductor wafer defect monitoring	356/237.5
24	<input checked="" type="checkbox"/>	US 5350428 A	19940927	11	Electrostatic apparatus and method for removing particles from semiconductor wafers	29/25.01
25	<input checked="" type="checkbox"/>	FR 2727663 A1	19960607		TITLE DATA NOT AVAILABLE	

	Current XRef	Retrieval Classif	Inventor	S	C	P	2	3	4	5	Image Doc. Displayed	PT
16	356/614; 430/22; 430/394	Leroux, Pierre et al.	<input type="checkbox"/>	US 5902703	<input type="checkbox"/>							
17	430/312; 430/394	Leroux, Pierre	<input type="checkbox"/>	US 5876883	<input type="checkbox"/>							
18	430/9	Leroux, Pierre	<input type="checkbox"/>	US 5856052	<input type="checkbox"/>							
19	356/399; 356/401; 382/145; 382/151	Leroux, Pierre et al.	<input type="checkbox"/>	US 5830610	<input type="checkbox"/>							
20	250/492.22; 430/322; 430/396; 430/494	Ziger, David et al.	<input type="checkbox"/>	US 5780298	<input type="checkbox"/>							
21	55/282; 95/237	Ziger, David H. et al.	<input type="checkbox"/>	US 5762688	<input type="checkbox"/>							
22	430/328; 430/394; 430/396; 430/397	Leroux, Pierre	<input type="checkbox"/>	US 5407785	<input type="checkbox"/>							
23	250/559.45	Savka, Anthony et al.	<input type="checkbox"/>	US 5392113	<input type="checkbox"/>							
24	134/1.3; 15/1.51; 438/906	Leroux, Pierre et al.	<input type="checkbox"/>	US 5350428	<input type="checkbox"/>							
25		LEROUX, PIERRE et al.	<input type="checkbox"/>		<input type="checkbox"/>							

[IEEE HOME](#) | [SEARCH IEEE](#) | [SHOP](#) | [WEB ACCOUNT](#) | [CONTACT IEEE](#)

[Membership](#) [Publications/Services](#) [Standards](#) [Conferences](#) [Careers/Jobs](#)

[Help](#) [FAQ](#) [Terms](#) [IEEE Peer Review](#) [Quick Links](#)

IEEE Xplore®
Welcome
United States Patent and Trademark Office

[View IEEE Xplore](#) [Advanced Search](#)

Try Our New Full-text Search Prototype [Go](#)

1) Enter a single keyword, phrase, or Boolean expression.
 Example: acoustic imaging (means the phrase acoustic imaging plus any stem variations)

2) Limit your search by using search operators and field codes, if desired.
 Example: optical <and> (fiber <or> fibre) <in> ti
 3) Limit the results by selecting Search Options.
 4) Click Search. See [Search Examples](#)

(centroid<or>center)
 <paragraph>(target<or>mark)
 <paragraph>(extrema<or>maxima<or>maximum)

[Start Search](#) [Clear](#)

By Author [Basic](#) [Advanced](#) [Refined Search](#)

Join IEEE [Establish IEEE Web Account](#) [Access the IEEE Member Digital Library](#)

Search Options:

Select publication types:

IEEE Journals IEE Journals
 IEEE Conference proceedings IEE Conference proceedings
 IEEE Standards

Select years to search:

From year: to

Organize search results by:

Sort by: Relevance Descending order
 In: List Results per page

Note: This function returns plural and suffixed forms of the keyword(s).

Search operators: <and> <or> <not> <in> [More](#)

Field codes: au (author), ti (title), ab (abstract), jn (publication name), de (index term) [More](#)

[IEEE HOME](#) | [SEARCH IEEE](#) | [SHOP](#) | [WEB ACCOUNT](#) | [CONTACT IEEE](#)

[Membership](#) [Publications/Services](#) [Standards](#) [Conferences](#) [Careers/Jobs](#)

[Help](#) [FAQ](#) [Terms](#) [IEEE Peer Review](#)

[Log In](#) [Forgot Your Password?](#)

IEEE Xplore®

Welcome
United States Patent and Trademark Office

[Quick Links](#)

Your search matched **0** of **1037503** documents.
A maximum of **500** results are displayed, **15** to a page, sorted by **Relevance** in **Descending** order.

Refine This Search:
You may refine your search by editing the current search expression or entering a new one in the text box.

(centroid<or>center)<paragraph>(target<or>mark)<part>

Check to search within this result set

Results Key:
JNL = Journal or Magazine **CNF** = Conference **STD** = Standard

By Author
 Basic
 Advanced

[Print Format](#)

[Log-out](#) | [Journals](#) | [Conference Proceedings](#) | [Standards](#) | [Search by Author](#) | [Basic Search](#) | [Advanced Search](#) | [Join IEEE](#) | [Web Account](#) | [New this week](#) | [OPAC Linking Information](#) | [Your Feedback](#) | [Technical Support](#) | [Email Alerting](#) | [No Robots Please](#) | [Release Notes](#) | [IEEE Online Publications](#) | [Help](#) | [FAQ](#) | [Terms](#) | [Back to Top](#)

